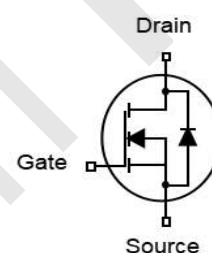


Features

- N-Channel
- Low gate charge
- Low reverse transfer capacitance
- Fast switching speed
- 100% Avalanche test
- 100% EAS Tested

V_{DS}	30	V
$R_{DS(on),TYP}@V_{GS}=10V$	1.1	$m\Omega$
I_D	160	A

DFN5x6



Part ID	Package Type	Marking	Packing
ZTG012N03GC	DFN5x6	ZTG012N03GC	5000pcs/Reel

Absolute Maximum Ratings $T_A=25^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter		Rating	Unit
Common Ratings (Tc=25°C Unless Otherwise Noted)				
V _{GS}	Gate-Source Voltage		±20	V
V _{(BR)DSS}	Drain-Source Breakdown Voltage		30	V
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	°C
I _{DM}	Drain Current-Continuous@ Current-Pulsed (Note 2)	T _C =25°C	640	A
Mounted on Large Heat Sink				
I _D	Drain Current-Continuous (Note 1)	T _C =25°C	160	A
		T _C =100°C	101	A
P _D	Maximum Power Dissipation (Note 3)		88	W
R _{θJC}	Thermal Resistance-Junction to Case		1.42	°C/W
R _{θJA}	Thermal Resistance Junction-Ambient		50	°C/W
Drain-Source Avalanche Ratings				
EAS	Avalanche Energy, Single Pulsed (Note 6)		342	mJ

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Electrical Characteristics @ T _j =25°C (unless otherwise stated)						
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	30	--	--	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V	--	--	1	μA
IGSS	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.2	--	2.2	V
RDS(on)	Drain-Source On-State Resistance	V _{GS} =10V, I _D =30A	--	1.1	1.4	mΩ
Dynamic Electrical Characteristics @ T _j = 25°C (unless otherwise stated) (Note 4.5)						
Ciss	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	--	3430	--	pF
Coss	Output Capacitance		--	1296	--	pF
Crss	Reverse Transfer Capacitance		--	77	--	pF
Rg	Gate Resistance	f=1MHz	--	1.9	--	Ω
Qg	Total Gate Charge	V _{DD} =15V, I _D =60A, V _{GS} =10V	--	48	--	nC
Qgs	Gate-Source Charge		--	11	--	nC
Qgd	Gate-Drain Charge		--	6	--	nC
V _{Plateau}	Gate Plateau Voltage		--	3.3	--	V
Switching Characteristics (Note 4.5)						
Td(on)	Turn-on Delay Time	V _{DD} =20V, I _D =30A, R _G =4.7Ω, V _{GS} =10V	--	10	--	ns
Tr	Turn-on Rise Time		--	30	--	ns
Td(off)	Turn-Off Delay Time		--	54	--	ns
Tf	Turn-Off Fall Time		--	15	--	ns
Source- Drain Diode Characteristics@ T _j = 25°C (unless otherwise stated)						
IS	Diode Forward Current		--	--	160	A
VSD	Forward on voltage	I _S =60A, V _{GS} =0V	--	--	1.4	V
Trr	Reverse Recovery Time (Note 4)	T _j =25°C, I _S = 60A	--	50	--	ns
Qrr	Reverse Recovery Charge	di/dt=100A/μs	--	59	--	nC

Notes:

1. The rating only refers to the maximum absolute value of 25°C in the specification. If the shell temperature is higher than 25°C , it needs to be derated according to the actual environmental conditions.
2. Pulse time 5 μs , pulse width is limited by the maximum junction temperature.
3. The dissipated power value will change with the change of temperature, when greater than 25°C , the dissipated power value will decrease by $0.7\text{ W}/^{\circ}\text{C}$ with the increase of 1°C of temperature.
4. Pulse test: pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
5. Basically unaffected by operating temperature.
6. EAS condition : $T_J=25^{\circ}\text{C}, V_{DD}=24V, L=0.5\text{mH}, R_g=25\Omega$

Typical Electrical and Thermal Characteristics

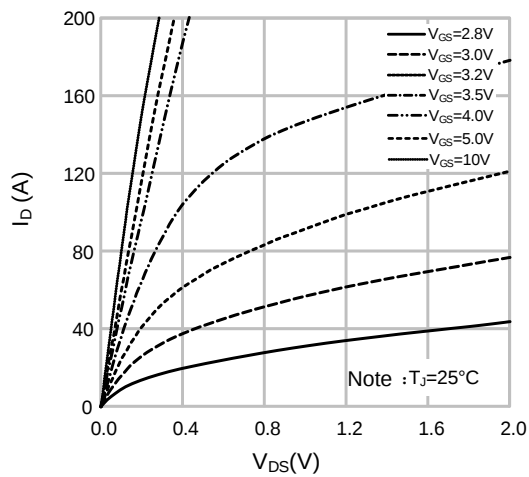


Figure 1 Output Characteristics

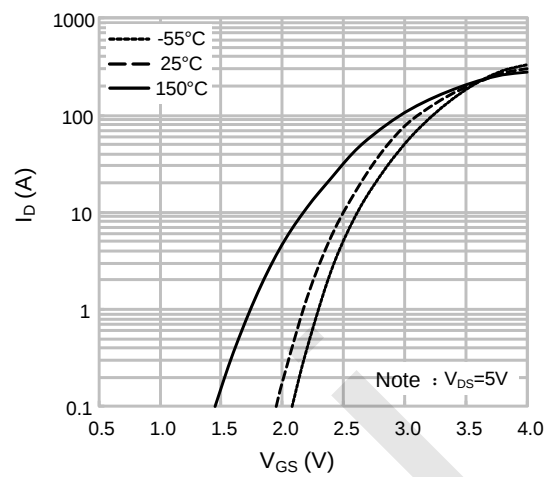


Figure 4 Transfer Characteristics

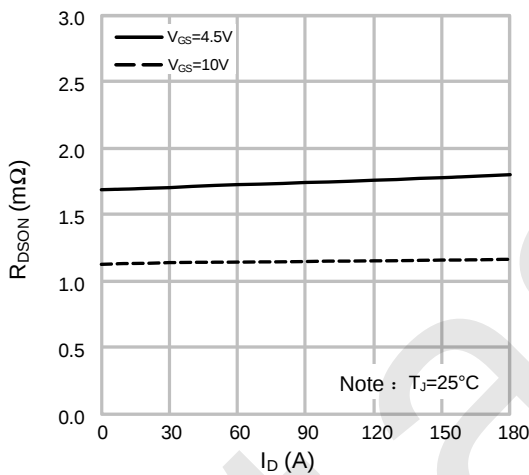


Figure 2 Rdson- Drain Current

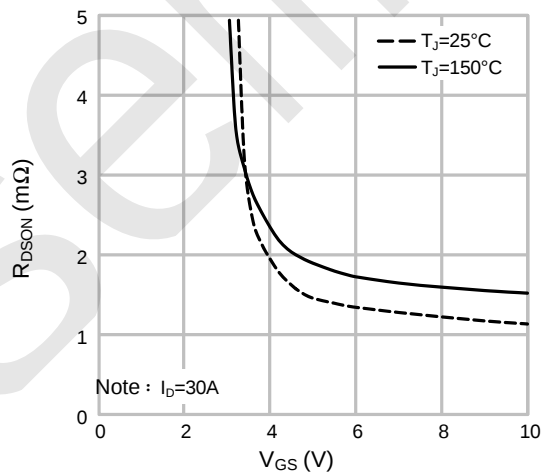


Figure 5 Rds(on) VS V_{GS}

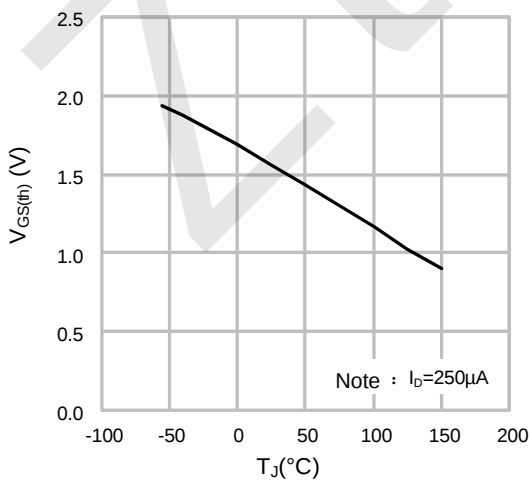


Figure 3 $V_{GS(th)}$ VS Temperature Characteristic

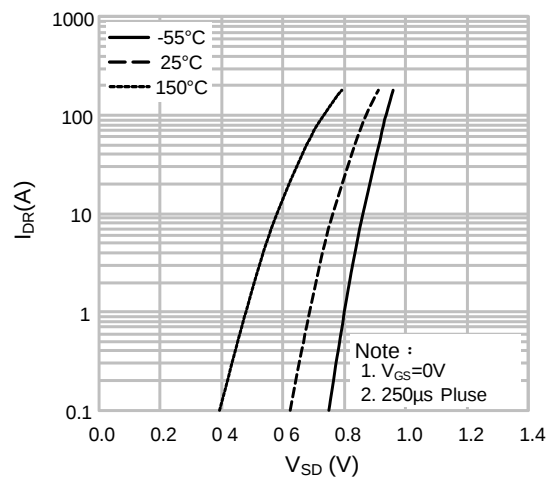


Figure 6 Body Diode Forward Voltage Drop VS Source Current and Temperature

Typical Electrical and Thermal Characteristics

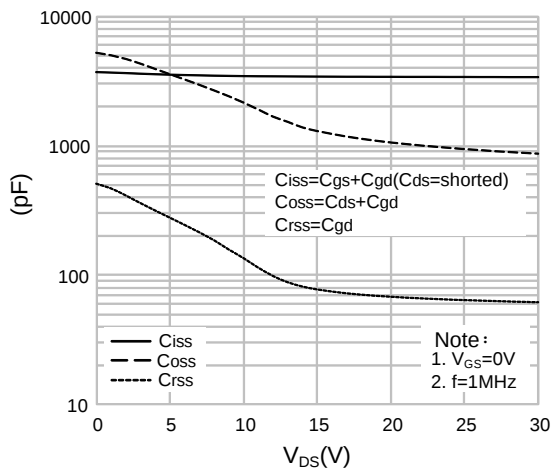


Figure 7 Capacitance Charateristics

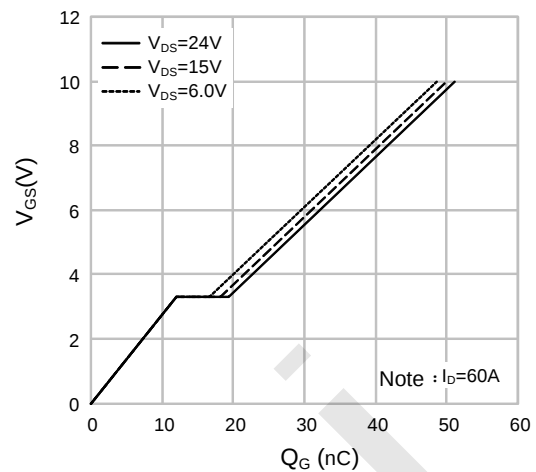


Figure 10 Gate Charge

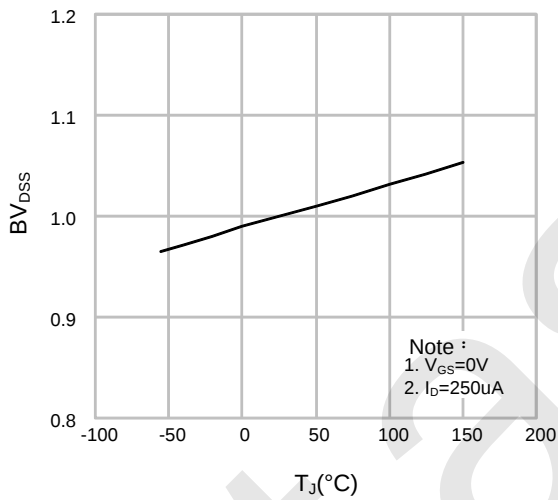


Figure 8 Breakdown Voltage VS Temperature Characteristic

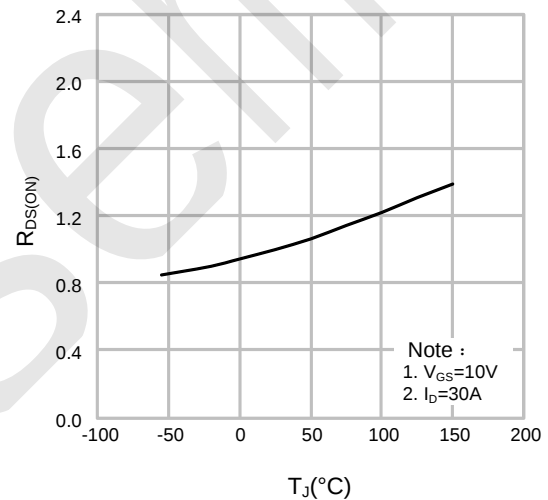


Figure 11 Rds(on) VS Temperature Characteristic

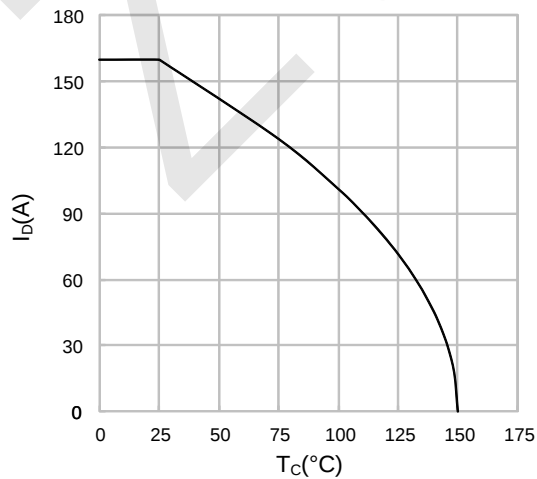


Figure 9 Drain Current VS Case Temperature

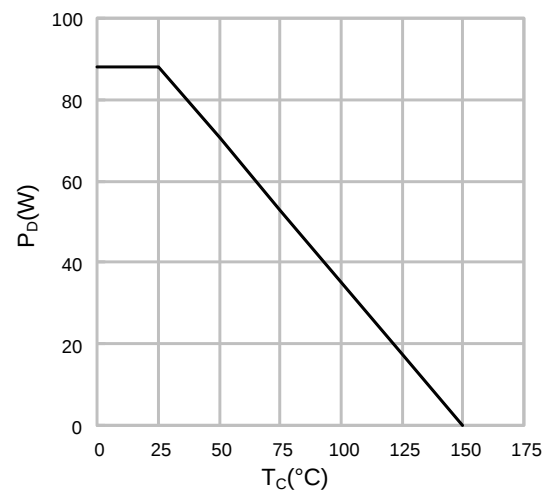


Figure 12 Power Dissipation VS Temperature

Typical Electrical and Thermal Characteristics

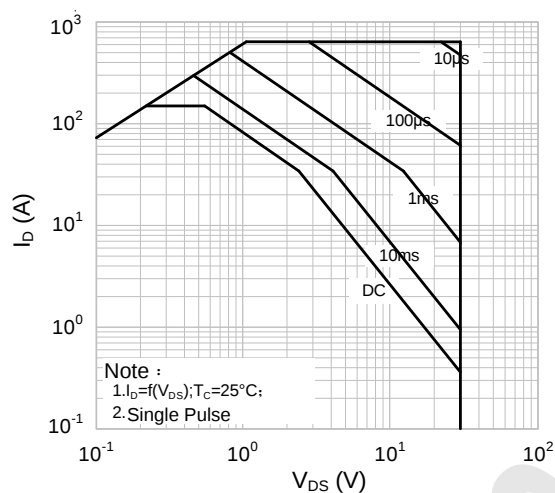


Figure 13 Safe Operation Area

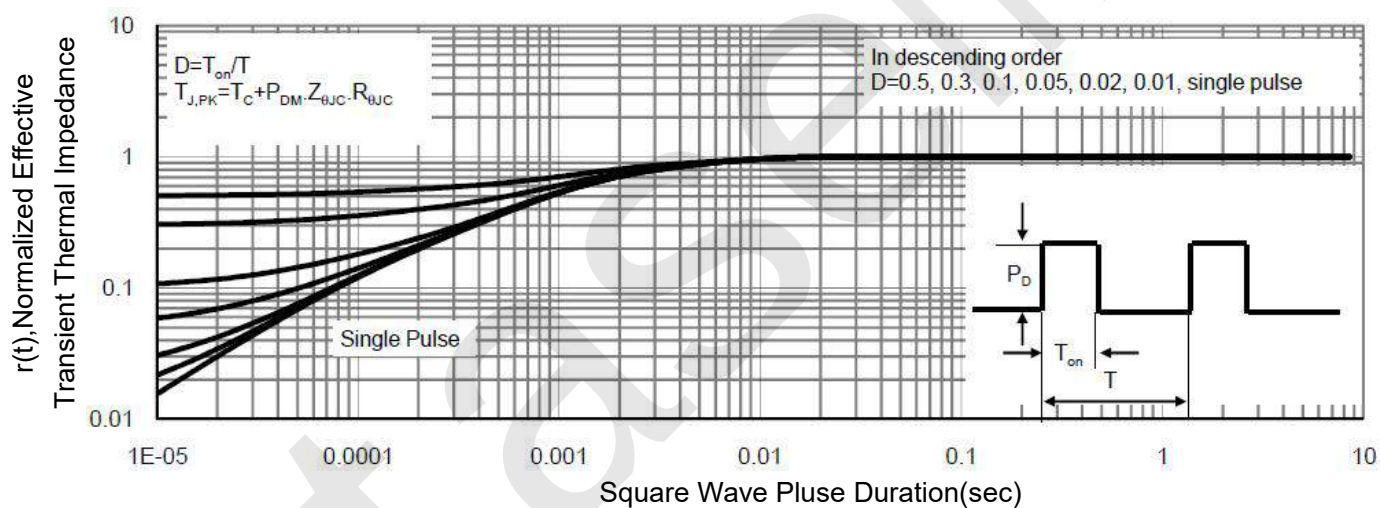
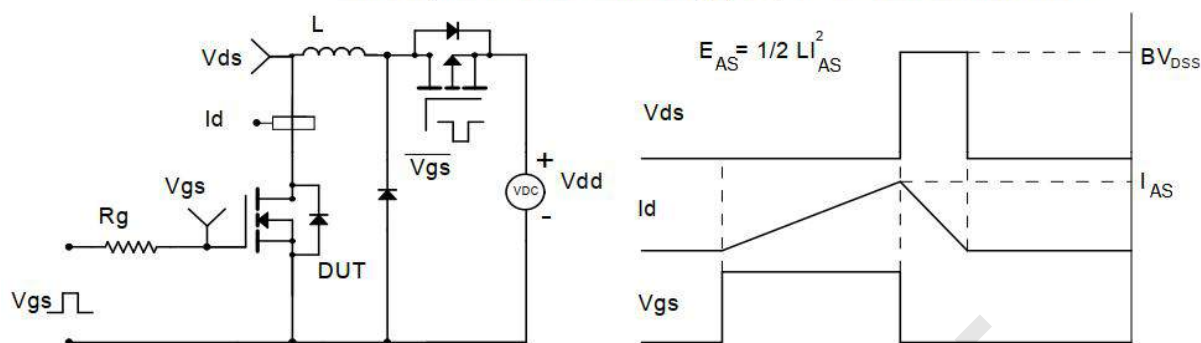


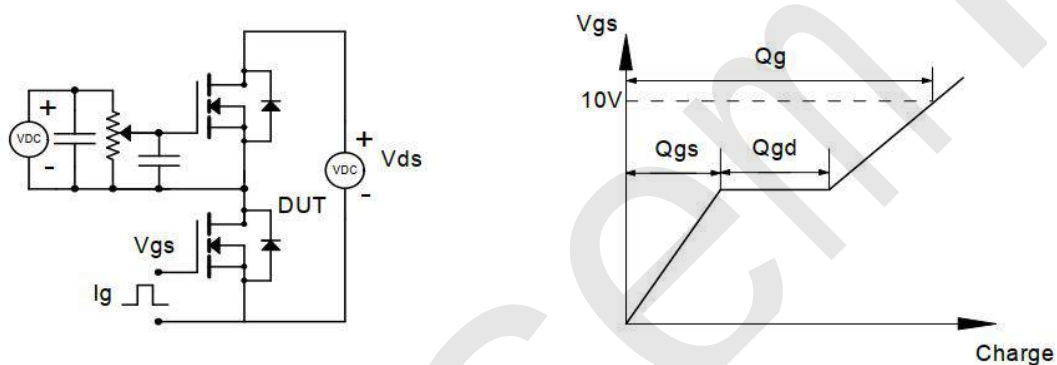
Figure 14 Normalized Maximum Transient Thermal Impedance

Test circuit&Waveform

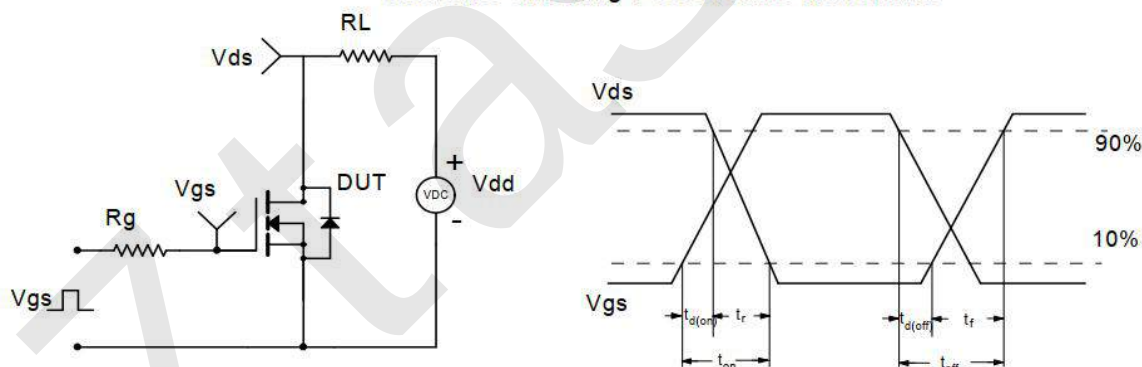
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



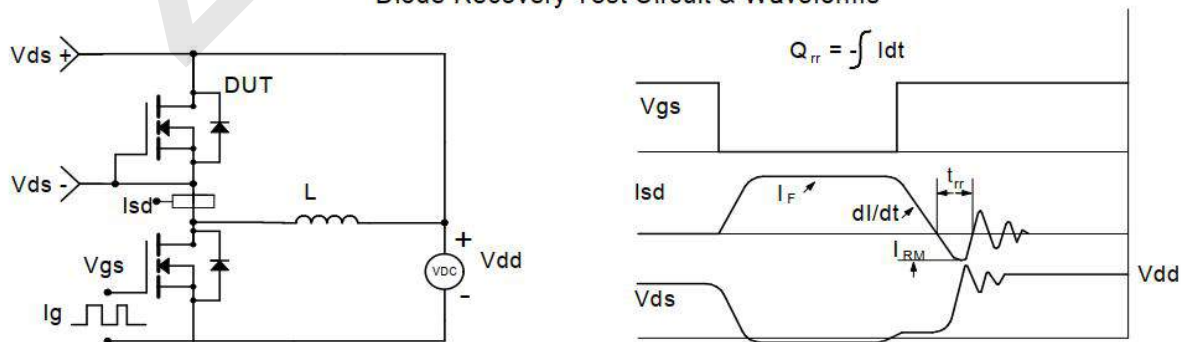
Gate Charge Test Circuit & Waveform



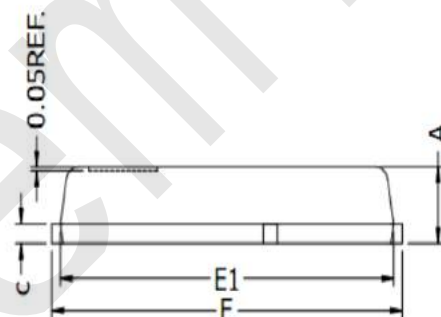
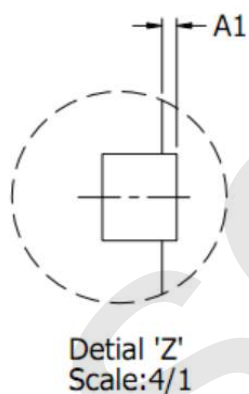
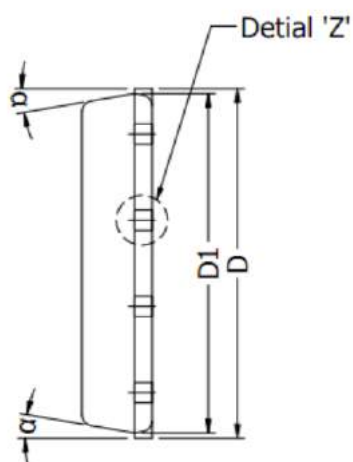
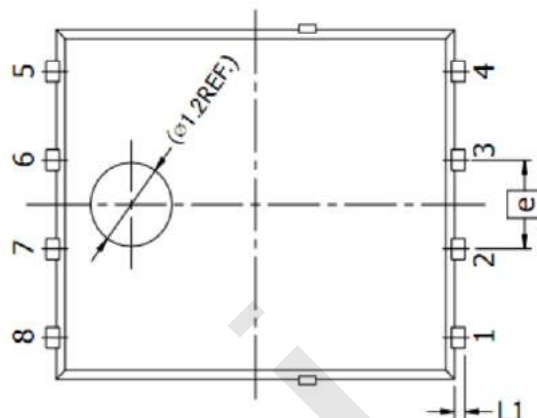
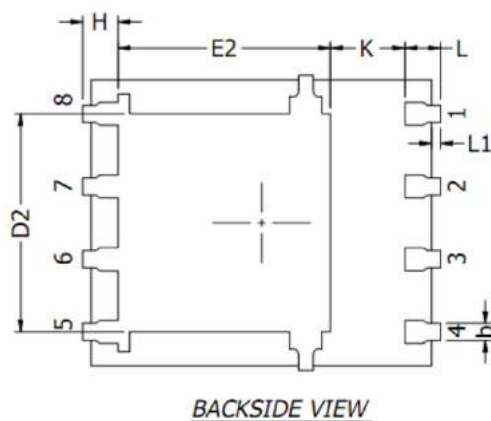
Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



DFN5x6-8L Package Information



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.30	0.40	0.50
c	0.20	0.25	0.30
D	5.15 BSC		
D1	5.00 BSC		
D2	3.76	3.81	3.86
E	6.15 BSC		
E1	5.80	5.85	5.90
E2	3.45	3.65	3.85
e	1.27 BSC		
H	0.51	0.61	0.71
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.08	0.15	0.23
α	10°	11°	12°

Customer Service

Sales and Service:

zj@ztasemi.com